



TEST REPORT

Test report no.: 1-3988/11-01-03-A



Testing laboratory

CETECOM ICT Services GmbH

Untertuerkheimer Strasse 6 – 10 66117 Saarbruecken / Germany Phone: + 49 681 5 98 - 0 Fax: + 49 681 5 98 - 9075 Internet: http://www.cetecom.com ict@cetecom.com

Accredited Testing Laboratory:

The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the Deutsche Akkreditierungsstelle GmbH (DAkkS)

The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with

the registration number: D-PL-12076-01-01 Area of Testing: Radio/Satellite Communications

Applicant

Alfred Kärcher GmbH & Co.

Alfred-Kärcher-Str. 28-40
71364 Winnenden / GERMANY
Phone: +49 7195 14-0
Fax: +49 7195 14-3458
Contact: Dieter Plachke

e-mail: dieter.plachke@de.kaercher.com

Phone: +49 7195 14-2374

Manufacturer

Alfred Kärcher GmbH & Co

Alfred-Kärcher-Str. 28-40 71364 Winnender / GERMANY

Test standard/s

47 CFR Part 15 Title 47 of the Code of Federal Regulations; Chapter I

Part 15 - Radio frequency devices

RSS - 210 Issue 8 Spectrum Management and Telecommunications - Radio Standards Specification

Low-power Licence-exempt Radiocommunication Devices (All Frequency Bands):

Category I Equipment

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item: RF-ID Module Model name: RFID B80W

FCC ID: ZP940353910999 IC: 9752A-40353910999

Frequency: 13.56 MHz
Technology tested: RFID

Antenna: Integrated print antenna

Power Supply: 5.0 V DC by external DC power supply

Temperature Range: -10°C to +45 °C



This test report is electronically signed and valid without handwriting signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

Test report authorised:	Test performed:
p.o.	
Marco Bertolino Testing Manager	Tobias Wittenmeier

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2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CETECOM ICT Services GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.

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In no case this test report can be considered as a Letter of Approval.

This test report is electronically signed and valid without handwritten signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

2.2 Application details

Date of receipt of order: 2011-11-03
Date of receipt of test item: 2012-07-17
Start of test: 2012-07-19
End of test: 2012-07-20

Person(s) present during the test: -/-

3 Test standard/s

Test standard	Date	Test standard description
47 CFR Part 15	2010-10	Title 47 of the Code of Federal Regulations; Chapter I Part 15 - Radio frequency devices
RSS - 210 Issue 8	2010-12	Spectrum Management and Telecommunications - Radio Standards Specification Low-power Licence-exempt Radiocommunication Devices (All Frequency Bands): Category I Equipment

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4 Test environment

T_{nom} +22 °C during room temperature tests

Temperature: T_{max} +45 °C during high temperature tests

T_{min} -10 °C during low temperature tests

Relative humidity content: 55 %

Barometric pressure: not relevant for this kind of testing

 V_{nom} 5.0 V DC by external DC power supply

Power supply: V_{max} 5.25 V

V_{min} 4.75 V

5 Test item

Kind of test item	:	RF-ID Module	
Type identification	:	RFID B80W	
S/N serial number	:	082	
HW hardware status	:	Rev. 01	
SW software status	:	Test software continuous reading mode	
Frequency band [MHz]	:	13.56 MHz	
Type of radio transmission	:	Single carrier	
Use of frequency spectrum	:	Single carrier	
Type of modulation	:	ASK	
Number of channels	:	1	
Antenna	:	Integrated print antenna	
Power supply	:	5.0 V DC by external DC power supply	
Temperature range	:	-10°C to +45 °C	

6 Test laboratories sub-contracted

None

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7	Summary of measurement results			
	\boxtimes	No deviations from the technical specifications were ascertained		
		There were deviations from the technical specifications ascertained		

TC Identifier	Description	Verdict	Date	Remark
RF-Testing	CFR Part 15 RSS 210, Issue 8	Passed	2012-08-14	-/-

Test Specification Clause	Test Case	Temperature Conditions	Power Source Voltages	Pass	Fail	NA	NP	Remark
§ 15.35 (c)/ RSS-GEN Issue 2 Section 4.5	Timing of the transmitter (Duty cycle correction factor)	Nominal	Nominal	\boxtimes				complies
§ 15.225 (a)/ RSS-210 Issue 8 Annex 2.6	Fieldstrength of Fundamental	Nominal	Nominal	\boxtimes				complies
§ 15.209/ RSS-210 Issue 8 Annex 2.6	Fieldstrength of harmonics and spurious	Nominal	Nominal					complies
§ 15.225 (e)/		Nominal	Extreme	\boxtimes				
RSS-210 Issue 8 Annex 2.6	Frequency tolerance	Extreme	Nominal	\boxtimes				complies

Note: NA = Not Applicable; NP = Not Performed

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8 RF measurements

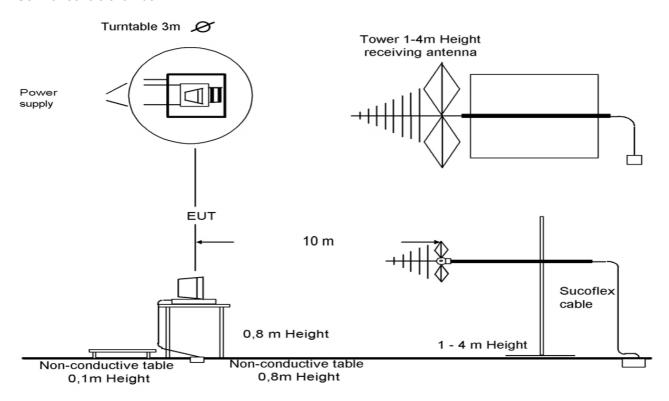
8.1 Description of test setup

8.1.1 Radiated measurements

The radiated measurements are performed in vertical and horizontal plane in the frequency range from 9 kHz to 25 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are confirmed with specifications ANSI C63.2-1996 clause 15 and ANSI C63.4-2003 clause 4.1.5. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analysers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63-4-2003 clause 4.2.

Antennas are confirmed with ANSI C63.2-1996 item 15.

Semi anechoic chamber



Picture 1: Diagram radiated measurements

9 kHz - 30 MHz: active loop antenna

30 MHz – 1 GHz: tri-log antenna

> 1 GHz: horn antenna

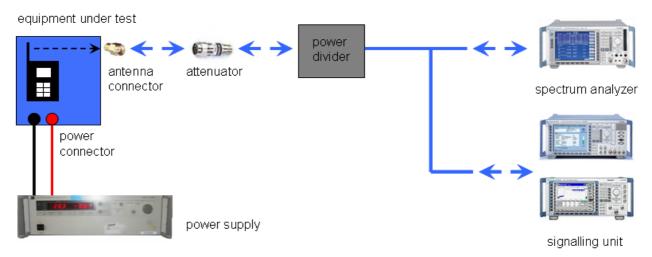
The EUT is powered by an external power supply with nominal voltage. The signalling is performed from outside the chamber with a signalling unit (CMU200 or other) by air link using signalling antenna.

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8.1.2 Conducted measurements

The EUT's RF signal is coupled out by the antenna connector which is supplied by the manufacturer. The signal is first 10dB attenuated before it is power divided (~6dB loss per branch). One of the signal paths is connected to the communication base Station (CMU200 or other), the other one is connected to the spectrum analyzer. The specific losses for both signal paths are first checked within a calibration. The measurement readings on the signalling unit/spectrum analyzer are corrected by the specific test set-up loss. The attenuator, power divider, signalling unit and the spectrum analyzer are impedance matched on 50 Ohm.



Picture 2: Diagram conducted measurements

8.2 Additional comments

The EUT is intended to be used in a battery powered device; therefore the AC-conducted measurements are not applicable.

Reference documents: None

Special test descriptions: None

Configuration descriptions: None

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8.3 RSP100 test report cover sheet / performance test data

Test Report Number	:	1-3988/11-01-03-A
Equipment Model Number	:	RFID B80W
Certification Number	:	9752A-40353910999
Manufacturer (complete Address)	:	Alfred Kärcher GmbH & Co Alfred-Kärcher-Str. 28-40 71364 Winnender / GERMANY
Tested to radio standards specification no.	:	RSS 210, Issue 8
Open Area Test Site IC No.	:	IC 3462C-1
Frequency Range or fixed frequency	:	13.56 MHz
Field Strength [dBµV/m] (at which distance)	:	52.5 dBμV/m @ 10m
Occupied bandwidth (99%-BW) [MHz]	:	22 Hz
Type of modulation	:	ASK
Emission Designator (TRC-43)	:	22H0N0N
Antenna Information	:	Integrated print antenna
Transmitter Spurious (worst case) [dBµV/m @ 3m]	:	29.10 dBμV/m @ 49.5 MHz
Receiver Spurious (worst case) [dBµV/m @ 3m]	:	Not applicable, only transmit mode available

ATTESTATION: DECLARATION OF COMPLIANCE:

I attest that the testing was performed or supervised by me; that the test measurements were made in accordance with the above-mentioned Industry Canada standard(s); and that the equipment identified in this application has been subjected to all the applicable test conditions specified in the Industry Canada standards and all of the requirements of the standard have been met.

Laboratory Manager:

2012-08-14	Tobias Wittenmeier	
Date	Name	Signature

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9 Measurement results

9.1 Timing of the transmitter

Measurement:

Measurement parameter			
Detector:	-/-		
Sweep time:	-/-		
Resolution bandwidth:	-/-		
Video bandwidth:	-/-		
Span:	-/-		
Trace-Mode:	-/-		

Limits:

FCC	IC		
CFR Part SUBCLAUSE § 15.35 (c)	RSS-GEN Issue 2 Section 4.5		
Timing of the transmitter			

(c) Unless otherwise specified, e.g. Section 15.255(b), when the radiated emission limits are expressed in terms of the average value of the emission, and pulsed operation is employed, the measurement field strength shall be determined by averaging over one complete pulse train, including blanking intervals, as long as the pulse train does not exceed 0.1 seconds. As an alternative (provided the transmitter operates for longer than 0.1 seconds) or in cases where the pulse train exceeds 0.1 seconds, the measured field strength shall be determined from the average absolute voltage during a 0.1 second interval during which the field strength is at its maximum value. The exact method of calculating the average field strength shall be submitted with any application for certification or shall be retained in the measurement data file for equipment subject to notification or verification.

Duty-Cycle: 100%

Result: passed

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9.2 Field strength of the fundamental

Measurement:

Measurement parameter			
Detector:	Quai Peak		
Sweep time:	Auto		
Resolution bandwidth:	200 Hz up to 150 kHz, 9 kHz up to 30 MHz, 120 kHz up to 1 GHz		
Video bandwidth:	≥ RBW		
Span:	Auto		
Trace-Mode:	Max Hold		

Limits:

FCC		IC		
CFR Part SUBCLAUSE § 15.225 (b)		RSS-210 Issue 8 Section A1.1.2 / 2.7 Table 4		
Fundamental Frequency (MHz)	Field strength of Fundamental (µV/m)		Measurement distance (m)	
	15848 μV/m (84 dBμV/m) 158489 μV/m (104 dBμV/m)		30	
13.553 to 13.567			10 (Recalculated acc. to FCC part15.31 (f2))	

Result:

TEST CO	ONDITIONS	MAXIMUM POV	VER (dBμV/m)		
Free	quency	13.56 MHz 13.56 MHz			
M	Mode		at 30 m distance		
T _{nom}	V _{nom}	52.5 32.5			
Measurement uncertainty		±30	dB		

^{*} Limits recalculated from 10m to 30m with 40 dB/decade according to FCC 15.31 (f2).

Result: passed

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9.3 Field strength of the harmonics and spurious

Measurement:

Measurement parameter				
Detector:	Quasi Peak / Average			
Sweep time:	Auto			
Resolution bandwidth:	100 kHz/ 1 MHz			
Video bandwidth:	> RBW			
Span:	Auto			
Trace-Mode:	Max. Hold			

Limits:

FCC			IC
SUBCLAUSE § 15.	SUBCLAUSE § 15.209		
Fie	eld strength of the ha	armonics and spi	urious.
Frequency (MHz)	Field streng	gth (μV/m)	Measurement distance (m)
0.0009 - 0.490	2400/F	(kHz)	300
0.490 – 1.705	24000/F	(kHz)	30
1.705 – 30	30 (29.5 c	IBμV/m)	30
30 – 88	100 (40 dBμV/m)		3
88 – 216	150 (43.5	dBµV/m)	3
216 – 960	200 (46 d	BµV/m)	3

Result:

	EMISSION LIMITATIONS						
f [MHz]	Detector	Limit max. allowed [dBµV/m]	Amplitude of emission [dBμV/m]	Results			
	No peaks detected						

Result: passed

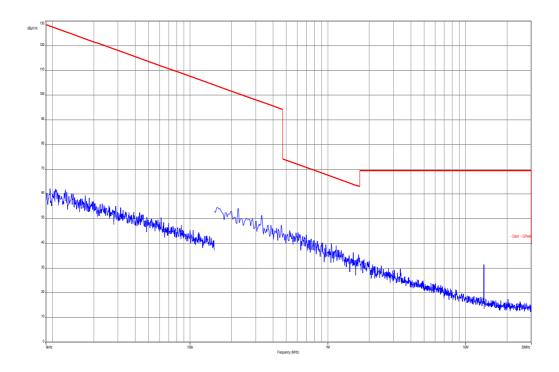
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Plots of the measurements

Plot 1: 9 kHz – 30 MHz; Part 15.209 Magnetics, Measurement distance 3m

Transmit frequency 13.56 MHz



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Plot 2: 30 MHz - 1000 MHz

Common Information

EUT: B80

Serial Number: 082 SW: 1.00

Test Description: FCC part 15 class B @ 10 m
Operating Conditions: continuous reading (without TAG)

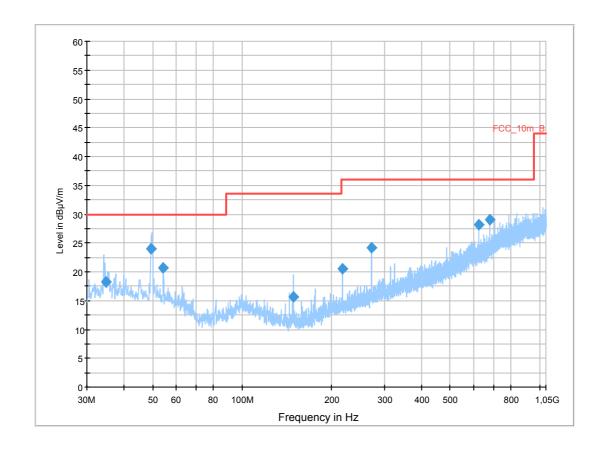
Operator Name: Hennemann Comment: DC: 5 V

Scan Setup: STAN_Fin [EMI radiated]

Hardware Setup: Electric Field (NOS)

Receiver: [ESCI 3] Level Unit: dBµV/m

SubrangeStep SizeDetectorsIF BWMeas. Time30 MHz - 2 GHz60 kHzQPK120 kHz1 s20 dB



Final Result 1

a	U.I.U.									
Frequency (MHz)	QuasiPe ak (dBµV/m)	Meas. Time (ms)	Bandwid th (kHz)	Height (cm)	Po lari zat ion	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBµV/m)	Comment
34.652100	18.3	1000.0	120.000	187.0	V	131.0	13.0	11.7	30.0	
49.455000	24.1	1000.0	120.000	100.0	V	91.0	13.4	5.9	30.0	
54.245100	20.6	1000.0	120.000	212.0	V	75.0	13.0	9.4	30.0	
148.575750	15.6	1000.0	120.000	100.0	V	121.0	8.9	17.9	33.5	
217.015650	20.5	1000.0	120.000	292.0	Н	-22.0	12.3	15.5	36.0	
271.248450	24.2	1000.0	120.000	265.0	Н	-19.0	13.8	11.8	36.0	
623.902050	28.2	1000.0	120.000	112.0	Н	0.0	20.9	7.8	36.0	
678.156750	29.1	1000.0	120.000	100.0	Н	26.0	21.9	6.9	36.0	

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Hardware Setup: EMI radiated\Electric Field (NOS) - [EMI radiated]

Subrange 1

Frequency Range: 30 MHz - 2 GHz

Receiver: Receiver [ESCI 3]

@ GPIB0 (ADR 20), SN 100083/003, FW 4.42

Signal Path: without Notch

FW 1.0

Antenna: VULB 9163

SN 9163-295, FW ---

Correction Table (vertical): VULP6113 Correction Table (horizontal): VULP6113

Correction Table (vertical): Cable_EN_1GHz (1005) Correction Table (horizontal): Cable_EN_1GHz (1005)

Antenna Tower: Tower [EMCO 2090 Antenna Tower]

@ GPIB0 (ADR 8), FW REV 3.12

Turntable: Turntable [EMCO Turntable]

@ GPIB0 (ADR 9), FW REV 3.12

EMC 32 Version 8.52

The transmitter holds the requirements of FCC 15.225 (a, b, c and d)

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9.4 Frequency tolerance

Measurement:

Measurement parameter					
Detector:	Peak				
Sweep time:	Auto				
Resolution bandwidth:	10 Hz				
Video bandwidth:	30 Hz				
Span:					
Trace-Mode:	Max hold				

Limits:

FCC	IC
SUBCLAUSE § 15.225	RSS-210 Issue 8 Annex 2.6

The frequency tolerance of the carrier signal shall be maintained within +/- 0.01% of the operating frequency over a temperature variation of -20 degrees to +50 degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees C.

Result: passed

Frequency tolerance								
	Over temperature variation	tion	Over voltage variation					
	Limit is +/- 1.356 kHz	7		Limit is +/- 1.356 kHz				
T [°C]	Frequency [MHz]	result	Power voltage	result				
-10°	13.562890	Pass	4.75 V	13.562834	Pass			
0°	13.562894	Pass	4.85 V	13.562834	Pass			
10°	13.562875	Pass	4.95 V	13.562834	Pass			
20°	13.562849	Pass	5.05 V	13.562833	Pass			
30°	13.562814	Pass	5.15 V	13.562832	Pass			
40°	13.562783	Pass	5.25 V	13.562833	Pass			
50°	13.562764	Pass						
Measurem	ent uncertainty	±100 Hz						

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9.5 AC line conducted

Not applicable

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10 Test equipment and ancillaries used for tests

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, rf-generating and signalling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Labor/Item).

No.	Lab / Item	Equipment	Туре	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	n. a.	Temperature Test Chamber	VT 4002	Heraeus Voetsch	521/83761	300002326	Ve	20.09.2011	20.09.2013
2	n. a.	MXA Signal Analyzer 20 Hz - 26.5 GHz	N9020A MXA Signal Analyzer	Agilent Vertr. Bad Hom	US46220229	300003805	vIKI!	08.09.2010	08.09.2012
3	n. a.	DC power supply, 60Vdc, 50A, 1200 W	6032A	HP Meßtechnik	2818A03450	300001040	Ve	12.01.2012	12.01.2015
4	n. a.	Active Loop Antenna	6502	EMCO	2210	300001015	ne		
5	n. a.	Anechoic chamber	FAC 3/5m	MWB / TDK	87400/02	300000996	ev		
6	Spec.A. 2_2e	System rack for EMI measurement solution	85900	HP I.V.	*	300000222	ne		
7	9	Artificial Mains 9 kHz to 30 MHz	ESH3-Z5	R&S	828576/020	300001210	Ve	06.01.2012	06.01.2014
8	n. a.	Relais Matrix	3488A	HP Meßtechnik	2719A15013	300001156	ne		
9	n. a.	Relais Matrix	PSU	R&S	890167/024	300001168	ne		
10	n. a.	Three-Way Power Splitter, 50 Ohm	11850C	HP Meßtechnik		300000997	ne		
11	n. a.	Switch / Control Unit	3488A	HP	2605e08770	300001443	ne		
12	n. a.	Amplifier	js42- 00502650- 28-5a	Parzich GMBH	928979	300003143	ne		
13	n. a.	Band Reject filter	WRCG185 5/1910- 1835/1925- 40/8SS	Wainwright	7	300003350	ev		
14	n. a.	Band Reject filter	WRCG240 0/2483- 2375/2505- 50/10SS	Wainwright	11	300003351	ev		
15	n. a.	Highpass Filter	WHKX2.9/1 8G-12SS	Wainwright	1	300003492	ev		
16	n. a.	Highpass Filter	WHK1.1/15 G-10SS	Wainwright	3	300003255	ev		
17	n. a.	Highpass Filter	WHKX7.0/1 8G-8SS	Wainwright	18	300003789	ne		
18	n. a.	RF Filter Section 9kHz - 1GHz	N9039A	Agilent Technologi es	MY48260003	300003825	vk	08.09.2010	
19	n. a.	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbe ck	371	300003854	vlKI!	14.10.2011	14.10.2014
20	n. a.	MXE EMI Receiver 20 Hz bis 26,5 GHz	N9038A	Agilent Technologi es	MY51210197	300004405	k	19.12.2011	19.12.2012

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Agenda: Kind of Calibration

calibration / calibrated ΕK limited calibration not required (k, ev, izw, zw not required) cyclical maintenance (external cyclical maintenance) ne ZW periodic self verification internal cyclical maintenance ev izw Ve long-term stability recognized blocked for accredited testing g Attention: extended calibration interval vlkl! Attention: not calibrated *) next calibration ordered / currently in progress NK!

11 Observations

No observations exceeding those reported with the single test cases have been made.

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Annex A Photographs of the test setup

Photo documentation:

Photo 1:

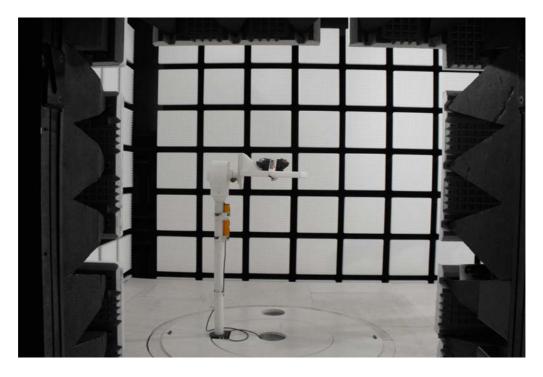
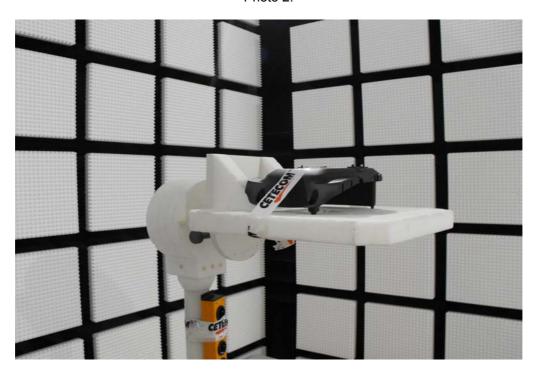


Photo 2:



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Photo 3:



Photo 4:



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Photo 5:



Photo 6:



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Annex B External photographs of the EUT

Photo documentation:

Photo 1:



Photo 2:



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Photo 3:



Photo 4:



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Photo 5:



Photo 6:



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Photo 7:



Photo 8:



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Annex C Internal photographs of the EUT

Photo documentation:

Photo 1:

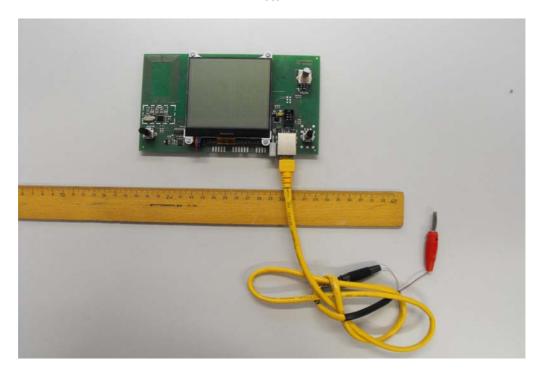
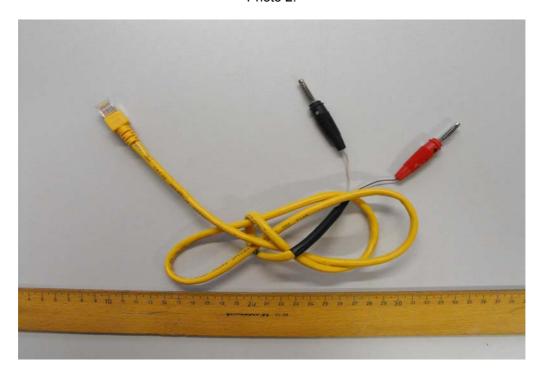


Photo 2:



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Photo 3:



Photo 4:



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Photo 5:

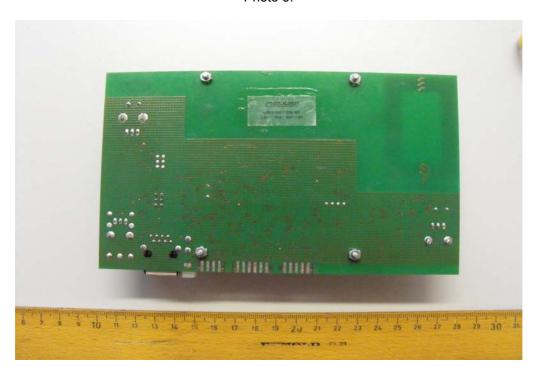


Photo 6:



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Photo 7:

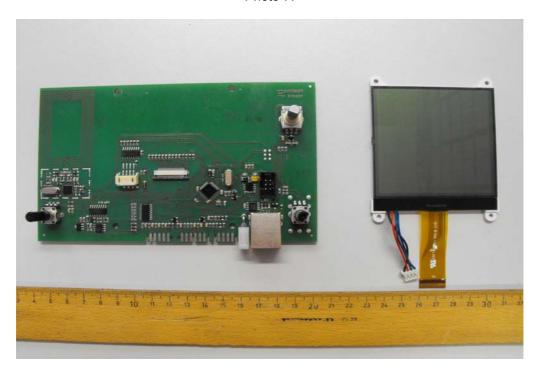
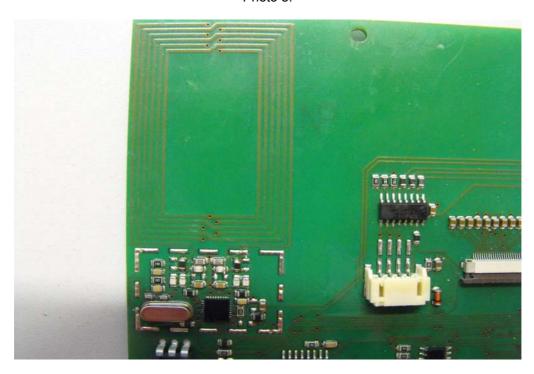


Photo 8:



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Photo 9:



Photo 10:



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Annex D **Document history**

Version	Applied changes	Date of release
1.0	Initial release	2012-07-25
-A	Correction of applicant, model name, and spurious worst case.	2012-08-14

Annex E **Further information**

Glossary

AVG Average

DUT Device under test

EMC Electromagnetic Compatibility

European Standard ΕN Equipment under test EUT

ETSI -FCC -FCC ID -European Telecommunications Standard Institute

Federal Communication Commission

Company Identifier at FCC

HW Hardware IC **Industry Canada** Inventory number Inv. No. -N/A Not applicable PP Positive peak

QΡ Quasi peak S/N Serial number Software SW

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Annex F Accreditation Certificate



Front side of certificate

Back side of certificate

Note:

The current certificate including annex is published on our website (see link below) or may be received from CETECOM ICT Services on request.

http://www.cetecom.com/fileadmin/de/CETECOM D Saarbruecken/accreditations Jan 2010/DAKKS Akkredi Urk EN17025-En incl Annex.pdf

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